



Test Report: DDR-120B-48

120W DC-DC DIN Rail Power Supply

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Control Function Test

Component Stress Test

■ SAFETY & E.M.C. TEST

Safety Test

E.M.C. Test

■ RELIABILITY TEST

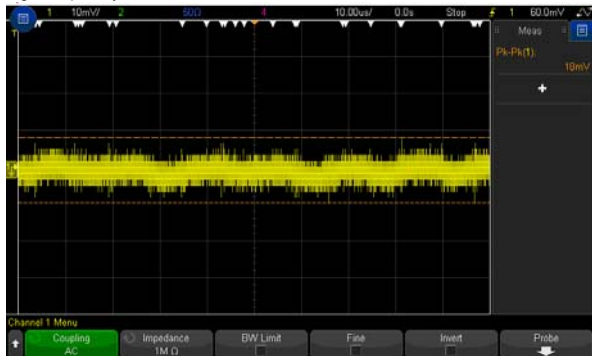
ENVIRONMENT TEST

DESIGN VERIFY TEST

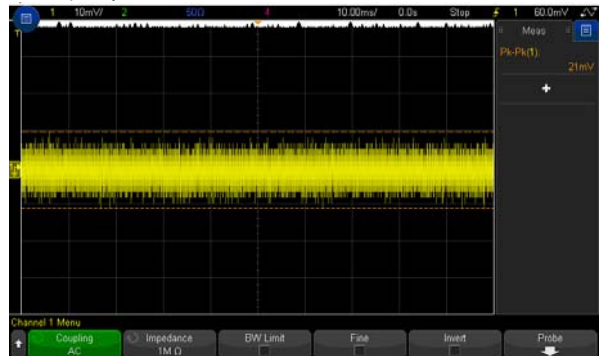
OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OUTPUT VOLTAGE ADJUST RANGE	CH1:48 V~56 V	I/P : 24 VDC O/P : MIN LOAD Ta : 25°C	47.0V~56.9V
2	OUTPUT VOLTAGE TOLERANCE (Max)	V1: -1 %~1 %	I/P:16.8VDC /33.6VDC O/P:FULL/ MIN. LOAD Ta:25°C	V1: -0.058 %~ 0.2 %
3	LINE REGULATION (Max)	V1: -0.5 %~0.5 %	I/P: 16.8VDC / 33.6VDC O/P:FULL LOAD Ta:25°C	V1: -0.19 %~ 0.12%
4	LOAD REGULATION (Max)	V1: -1 %~ 1 %	I/P:24VDC O/P:FULL ~MIN LOAD Ta:25°C	V1: -0.058 %~ 0.2 %
5	OVER/UNDERSHOOT TEST	< ±5%	I/P: 24VDC O/P:FULL LOAD Ta:25°C	TEST: 1.3 %
6	RIPPLE & NOISE (Max)	V1: 50 mVp-p	I/P: 24VDC O/P:FULL LOAD Ta:25°C	V1: 21 mVp-p

high frequency :



low frequency :

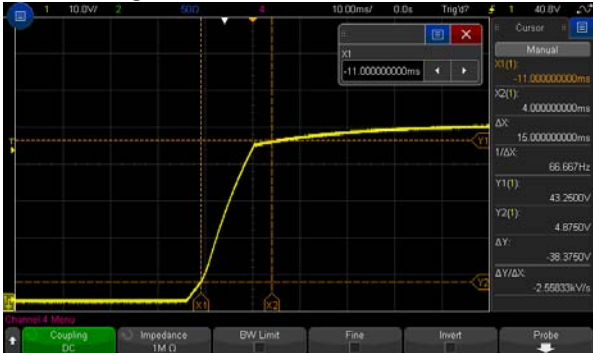


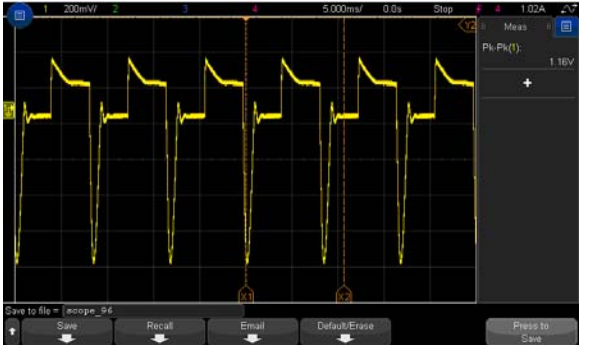
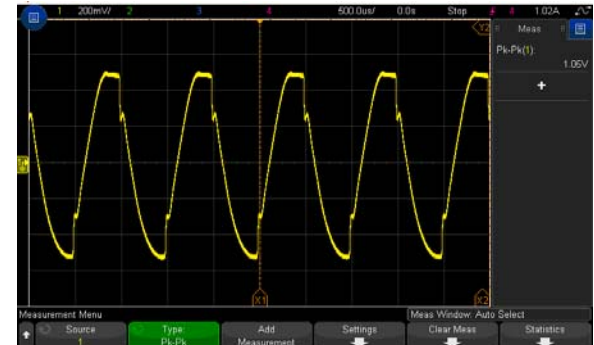


7	SET UP TIME (Max)	24VDC/ 500 ms	I/P: 24VDC O/P:FULL LOAD Ta:25°C	24VDC/ 266 ms
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INPUT=24VDC @ FULL LOAD

CH1 : Output Voltage CH4 : DC Input Voltage



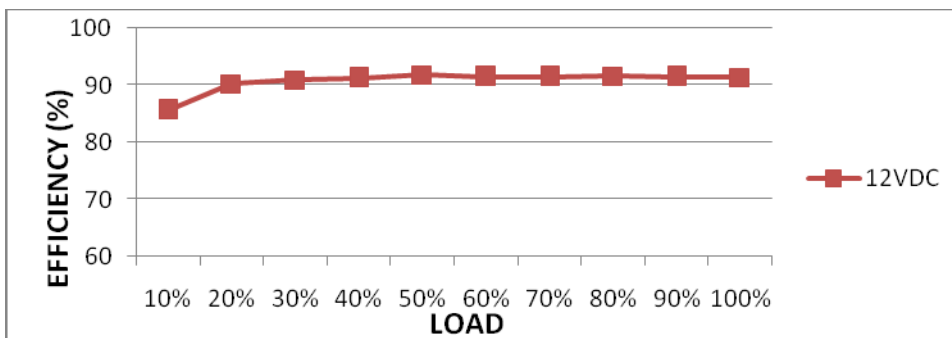
8	RISE TIME (Max)	24VDC/ 60 ms	I/P: 24VDC O/P:FULL LOAD Ta:25°C	24VDC/ 15 ms
<p>INPUT=24VDC @ FULL LOAD</p> 				
9	HOLD UP TIME (TYP)	24VDC/ 6 ms @FULL LOAD 24VDC/ 10 ms @70% LOAD	I/P: 24VDC O/P:FULL LOAD Ta:25°C	24VDC/8.1 ms@FULL LOAD 24VDC/11.6 ms@70%LOAD
<p>INPUT=24VDC @ FULL LOAD CH1 : Output Voltage CH4 :DC Input Voltage</p>  <p>INPUT=24VDC @ 70% LOAD CH1 : Output Voltage CH4 :DC Input Voltage</p> 				
10	DYNAMIC LOAD	V1: 4800 mVp-p	I/P: 24VDC O/P: (1)FULL /MIN LOAD 50%DUTY / 120HZ (2)FULL /MIN LOAD 50%DUTY / 1KHZ Ta:25°C	1050mVp-p 1160 mVp-p
<p>FULL /MIN LOAD 50%DUTY / 120HZ</p>  <p>FULL /MIN LOAD 50%DUTY / 1KHZ</p> 				

INPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	INPUT VOLTAGE RANGE	16.8VDC~ 33.6VDC	I/P:TESTING O/P:FULL LOAD Ta:25°C	15.957V~ 33.6V

			I/P: LOW-LINE-0.2= 16.6 V HIGH-LINE+3V= 36.6V O/P:FULL/MIN LOAD (PLEASE CHECK DERATING CURVE) ON: 30 Sec . OFF: 30 Sec 10MIN (POWER ON/OFF NO DAMAGE)	TEST: OK
2	INPUT CURRENT(TYP)	24VDC/5.6A	I/P:24VDC O/P:FULL LOAD Ta:25°C	I = 5.451 A/ 24VDC
3	EFFICIENCY(TYP)	91 %	I/P: 24VDC O/P:FULL LOAD Ta:25°C	91.42%

EFFICIENCY vs LOAD



4	INRUSH CURRENT(TYP)	24VDC / 5 A COLD START	I/P: 24VDC O/P:FULL LOAD Ta:25°C	I = 3.68A/24 VDC
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INPUT=24VDC @ FULL LOAD



PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	OVER LOAD PROTECTION	105%~135%RATED OUTPUT POWER	I/P: 33.6VDC I/P: 24VDC I/P: 16.8VDC O/P:TESTING Ta:25°C	125.4%/ 33.6VDC 124.8%/24VDC 126.68%/ 16.8VDC PROTECTION TYPE : Normally works within 105~150% rated output power for more than 3 seconds and then constant current protection with auto-recovery >150% rated power ,constant current limiting with auto-recovery



2	OVER VOLTAGE PROTECTION	CH: 57.6V~ 67.2V	I/P: 33.6VDC I/P:24VDC I/P: 16.8VDC O/P:MIN LOAD Ta:25°C	62V/33.6VDC 61.6V/24 VDC 61.2V/ 16.8VDC PROTECTION TYPE : Shut down O/P voltage,re-power on to recover
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P: 33.6 VDC O/P: FULL LOAD Ta:25°C	NO DAMAGE PROTECTION TYPE : Normally works within 105~150% rated output power for more than 3 seconds and then constant current protection with auto-recovery >150% rated power ,constant current limiting with auto-recovery
6.	INPUT REVERSE	POWER OK	I/P:33.6 VDC O/P: NO LOAD Ta:25°C	NO DAMAGE

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	PWM Transistor (D to S) or (C to E) Peak Voltage	Q5 Rated : 100 V Q6 Rated : -100 V	I/P:High-Line +3V =36.6V DC ON/OFF VDS: O/P: (1)Full Load (2)Output Short (3) Full Load continue Ta:25°C	Q5 Q6 VDS: VDS: (1) 97.5 V (1) -63.2 V (2) 126.4 V (2) -58.8 V (3) 56 V (3) -58.8 V
2	Diode Peak Voltage	Q100 Rated : 400V Q101 Rated : 400V	I/P:High-Line +3V =36.6V DC ON/OFF O/P: (1)Full Load (2)Output Short (3) Full Load continue Ta:25°C	Q100: Q101 VDS: VDS (1) 254 V (1) 355 V (2) 117.6 V (2) 367 V (3) 88.6 V (3) 351 V
3	Input Capacitor Voltage	C5 Rated: : 1200 μ / 35 V	I/P:High-Line +3V =33.6 V O/P: (1)Full Load input on/off (2) Min load input on /Off (3)Full Load /Min load Change (4)Full load continue Ta:25°C	C5: (1) 34.3 V (2) 34.3 V (3) 34.3 V (4) 33.9 V
4	Control IC Voltage Test	PWM IC U1 Rated -0.3V~16V	I/P:High-Line +3V =36.6 V DC ON/OFF O/P(1)FULL LOAD (2) Output Short (3)O.L.P (4)O.V.P. Ta:25°C	U1: (1) 14.6V (2) 14.6 V (3) 14.78 V (4) 15.1 V

SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	WITHSTAND VOLTAGE	I/P-O/P:4KVDC/min I/P-FG:2.5 KVDC/min O/P-FG:2.5KVDC/min	I/P-O/P: 4.4KVDC/min I/P-FG: 3 KVDC/min O/P-FG:3KVDC/min Ta:25°C	I/P-O/P: 0 mA I/P-FG: 0 mA O/P-FG: 0 mA NO DAMAGE



2	ISOLATION RESISTANCE	I/P-O/P:500VDC>100MΩ I/P-FG: 500VDC>100MΩ O/P-FG:500VDC>100MΩ	I/P-O/P: 500 VDC I/P-FG: 500 VDC O/P-FG: 500 VDC Ta:25°C	I/P-O/P: 9999MΩ I/P-FG: 9999 MΩ O/P-FG:9999 MΩ NO DAMAGE
3	GROUNDING CONTINUITY	FG(PE) TO CHASSIS OR TRACE < 100 mΩ	40A / 2min Ta:25°C	10mΩ

E.M.C TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
1	RADIATION	<input checked="" type="checkbox"/> EN55032 <input type="checkbox"/> EN55011 <input type="checkbox"/> CLASS A <input checked="" type="checkbox"/> CLASS B	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	<input checked="" type="checkbox"/> PASS <input type="checkbox"/> FAIL Test by certified Lab
2	CONDUCTION	<input checked="" type="checkbox"/> EN55032 <input type="checkbox"/> EN55011 <input type="checkbox"/> CLASS A <input checked="" type="checkbox"/> CLASS B	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	<input checked="" type="checkbox"/> PASS <input type="checkbox"/> FAIL Test by certified Lab
3	E.S.D	EN61000-4-2 <input type="checkbox"/> Din rail Model : AIR: 8KV / Contact: 6KV	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	<input checked="" type="checkbox"/> CRITERIA A <input type="checkbox"/> CRITERIA B
4	E.F.T	EN61000-4-4 <input type="checkbox"/> INDUSTRY INPUT: 2KV	I/P: 24VDC O/P:FULL LOAD Ta:25°C	<input checked="" type="checkbox"/> CRITERIA A <input type="checkbox"/> CRITERIA B
5	SURGE	IEC61000-4-5 <input type="checkbox"/> INDUSTRY L-N :1KV L,N-FG:2KV	I/P: 24 VDC O/P:FULL LOAD Ta:25°C	<input checked="" type="checkbox"/> CRITERIA A <input type="checkbox"/> CRITERIA B
6	Test by certified Lab & Test Report Prepare			

■ RELIABILITY TEST

ENVIRONMENT TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT
2	TEMPERATURE RISE TEST	MODEL : DDR-120B-24 1. ROOM AMBIENT BURN-IN : 1 HRS I/P : 24VDC O/P : FULL LOAD Ta= 24.0 °C 2. HIGH AMBIENT BURN-IN : 1 HRS I/P : 24VDC O/P : FULL LOAD Ta= 51.2 °C		



		NO	Position	ROOM AMBIENT Ta= 24.0 °C	HIGH AMBIENT Ta= 51.2 °C
		1	C104	50.5°C	79.4°C
		2	C106	62.3°C	92.8°C
		3	ZNR1	51.7°C	82.9°C
		4	LF1	63.6°C	94.8°C
		5	LF2	64.1°C	96.1°C
		6	T1	67.7°C	96.9°C
		7	T2	63.9°C	94.0°C
		8	Q1	57.3°C	88.8°C
		9	Q2	57.5°C	89.0°C
		10	Q5	62.1°C	91.7°C
		11	Q6	65.9°C	96.2°C
		12	Q100	65.4°C	94.1°C
		13	Q101	67.5°C	95.8°C
		14	L100	79.5°C	108.8°C
		15	C1	58.2°C	88.7°C
		16	C5	58.0°C	89.4°C
		17	C6	50.7°C	81.1°C
		18	C7	55.1°C	85.1°C
		19	C8	67.3°C	96.6°C
		20	C101	58.1°C	86.8°C
		21	C102	58.3°C	87.3°C
3	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)		I/P : 24 VDC O/P : 120 % LOAD Ta : 25°C	TEST : OK
4	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 2 HOUR		I/P : 16.8 VDC/ 33.6 VDC O/P : 100 % LOAD Ta= -45 °C	TEST : OK
5	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TURN ON TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 55 °C NO DAMAGE		I/P : 36.6 VDC O/P : FULL LOAD Ta= 55 °C HUMIDITY= 95 %R.H	TEST : OK
6	TEMPERATURE COEFFICIENT	± 0.03 %(0~55°C)		I/P : 24 VDC O/P : FULL LOAD	± 0.0046 %(0~55°C)
7	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -45°C~ +90°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : STATIC			TEST : OK
8.	THERMAL SHOCK TEST	1. Thermal shock Temperature : -45°C~ +60°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 16 CYCLE 5. Input/Output condition : 24VDC/Full Load DC ON/OFF TEST turn on 3sec ; turn off 1sec@15cycle\ 24VDC/Full Load DC ON@1cycle			TEST : OK



9	VIBRATION TEST	<p>1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10~500Hz (3) Sweep Time : 10min/sweep cycle (4) Acceleration : 5G (5) Test Time : 60min in each axis (X.Y.Z) (6) Ta : 25°C</p> <p>2 Din Rail</p> <table border="1" data-bbox="470 510 1157 645"> <thead> <tr> <th></th> <th>Displacement</th> <th>Acceleration</th> </tr> </thead> <tbody> <tr> <td>2 (+3/-0) Hz up to 15Hz</td> <td>±2.5mm</td> <td>-----</td> </tr> <tr> <td>15Hz up to 50Hz</td> <td>-----</td> <td>2.3g</td> </tr> <tr> <td>Sweep rate</td> <td colspan="2">Max 1 Octave/minute</td> </tr> </tbody> </table>		Displacement	Acceleration	2 (+3/-0) Hz up to 15Hz	±2.5mm	-----	15Hz up to 50Hz	-----	2.3g	Sweep rate	Max 1 Octave/minute		TEST : OK
	Displacement	Acceleration													
2 (+3/-0) Hz up to 15Hz	±2.5mm	-----													
15Hz up to 50Hz	-----	2.3g													
Sweep rate	Max 1 Octave/minute														
10	CAPACITOR LIFE CYCLE	<p>SUPPOSE C102 IS THE MOST CRITICAL COMPONENT</p> <p>(1) I/P : 24VDC O/P : FULL LOAD Ta= 25 °C LIFE TIME (2) I/P : 24VDC O/P : FULL LOAD Ta= 55 °C LIFE TIME (3) I/P : 24VDC O/P : 75% LOAD Ta= 55 °C LIFE TIME (4) I/P : 24VDC O/P : 50% LOAD Ta= 55 °C LIFE TIME</p>	<p>(1) 189691.3 HRS (2) 29631.8 HRS (3) 70144.5 HRS (4) 117739.2 HRS</p>												
11	MTBF	<p>Conducted by Parts Stress Analysis Prediction 214.6K hrs min. MIL-HDBK-217F (25°C)</p>													
12	DMTBF/Accelerated Life Test	<p>Demonstration Mean Time Between Failure (Expected Life): Above30,000 hours @ TA 55°C</p>													

TEST RESULT	TESTER	REVIEW	APPROVAL
PASS	LIUTT		WANGDZ

12.10.30 A50-F031